

U74AUP1G86

CMOS IC

SINGLE 2-INPUT
EXCLUSIVE-OR GATE

■ DESCRIPTION

The **U74AUP1G86** is a single 2-input EXCLUSIVE-OR gate which provides the Function $Y = A \oplus B$ or $Y = \bar{A}B + A\bar{B}$ in positive logic.

This device ensures a very low static and dynamic power consumption across the entire V_{CC} range from 0.8V to 3.6V.

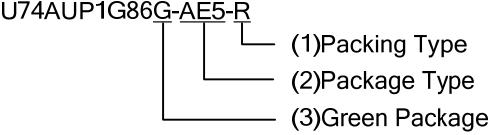
This device has power-down protective circuit, preventing device destruction when it is powered down.

■ FEATURES

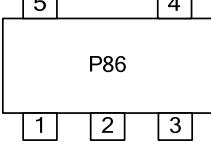
- * Wide supply voltage range from 0.8V to 3.6V
- * Inputs accept voltages up to 3.6V
- * I_{OFF} supports partial-power-down mode
- * Low static power consumption; $I_{CC}=0.5\mu A$ (Max.)
- * Optimized for 3.3V Operation

■ ORDERING INFORMATION

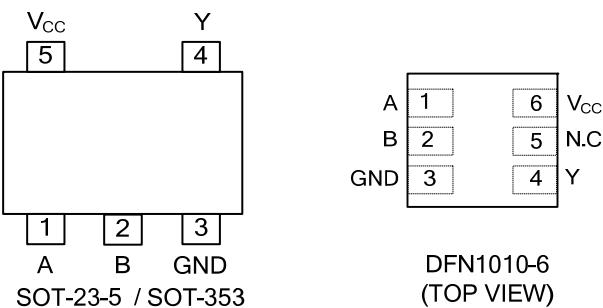
Ordering Number		Package	Packing
Lead Free	Halogen Free		
U74AUP1G86L-AE5-R	U74AUP1G86G-AE5-R	SOT-23-5	Tape Reel
U74AUP1G86L-AL5-R	U74AUP1G86G-AL5-R	SOT-353	Tape Reel
U74AUP1G86L-K06-1010-R	U74AUP1G86G-K06-1010-R	DFN1010-6	Tape Reel

 U74AUP1G86G-AE5-R	(1) R: Tape Reel (2) AE5: SOT-23-5, AL5: SOT-353, K06-1010: DFN1010-6 (3) G: Halogen Free and Lead Free, L: Lead Free
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■ MARKING

SOT-23-5 / SOT-353	DFN1010-6
 SOT-23-5 / SOT-353	 DFN1010-6

■ PIN CONFIGURATION



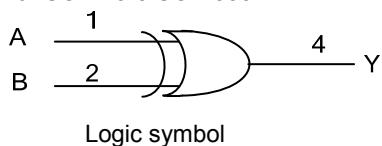
■ FUNCTION TABLE

INPUT(A)	INPUT(B)	OUTPUT(Y)
L	L	L
L	H	H
H	L	H
H	H	L

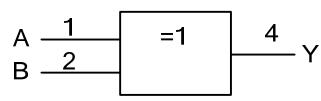
Note: H: HIGH voltage level; L: LOW voltage level.

■ LOGIC DIAGRAM (positive logic)

For SOT-23-5/SOT-353

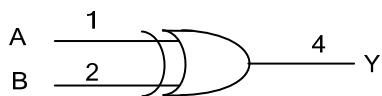


Logic symbol

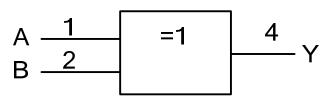


IEC logic symbol

For DFN1010-6



Logic symbol



IEC logic symbol

■ ABSOLUTE MAXIMUM RATING

PARAMETER	SYMBOL	CONDITIONS	RATINGS	UNIT
Supply Voltage	V _{CC}		-0.5 ~+4.6	V
Input Voltage	V _{IN}		-0.5 ~+4.6	V
Output Voltage	V _{OUT}	Output in the high or low state	-0.5 ~ V _{CC} +0.5	V
		Output in the power-off state	-0.5 ~ +4.6	V
Continuous V _{CC} or GND Current	I _{CC}		±50	mA
Continuous Output Current	I _{OUT}	V _{OUT} =0 ~ V _{CC}	±20	mA
Input Clamp Current	I _{IK}	V _{IN} <0	-50	mA
Output Clamp Current	I _{OK}	V _O >V _{CC} or V _{OUT} <0	-50	mA
Storage Temperature Range	T _{STG}		-65 ~+150	°C

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Supply Voltage	V _{CC}	Operating	0.8		3.6	V
Input Voltage	V _{IN}		0		3.6	V
Output Voltage	V _{OUT}	High or low state	0		V _{CC}	V
Operating Temperature	T _A		-40		85	°C
Input Transition Rise or Fall Rate	Δt/Δv	V _{CC} =0.8V ~ 3.6V			200	ns/V

■ ELECTRICAL CHARACTERISTICS (T_A =25°C , unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
High-level Input Voltage	V _{IH}	V _{CC} =0.8V		V _{CC}		V
		V _{CC} =1.1V ~ 1.95V		0.65×V _{CC}		V
		V _{CC} =2.3V ~2.7V		1.6		V
		V _{CC} =3V ~3.6V		2		V
Low-level Input Voltage	V _{IL}	V _{CC} =0.8V			0	V
		V _{CC} =1.1V ~ 1.95V			0.35×V _{CC}	V
		V _{CC} =2.3V ~2.7V			0.7	V
		V _{CC} =3V ~3.6V			0.9	V
High-Level Output Voltage	V _{OH}	V _{CC} =0.8 ~ 3.6V, I _{OH} =-20μA		V _{CC} -0.1		V
		V _{CC} =1.1V, I _{OH} =-1.1mA		0.75×V _{CC}		V
		V _{CC} =1.4V, I _{OH} =-1.7mA		1.11		V
		V _{CC} =1.65V, I _{OH} =-1.9mA		1.32		V
		V _{CC} =2.3V	I _{OH} =-2.3mA	2.05		V
			I _{OH} =-3.1mA	1.9		V
		V _{CC} =3V	I _{OH} =-2.7mA	2.72		V
			I _{OH} =-4mA	2.6		V
Low-Level Output Voltage	V _{OL}	V _{CC} =0.8 ~ 3.6V, I _{OL} =-20μA			0.1	V
		V _{CC} =1.1V, I _{OL} =-1.1mA			0.3×V _{CC}	V
		V _{CC} =1.4V, I _{OL} =-1.7mA			0.31	V
		V _{CC} =1.65V, I _{OL} =-1.9mA			0.31	V
		V _{CC} =2.3V	I _{OL} =2.3mA		0.31	V
			I _{OL} =3.1mA		0.44	V
		V _{CC} =3V	I _{OL} =2.7mA		0.31	V
			I _{OL} =4mA		0.44	V

■ ELECTRICAL CHARACTERISTICS (Cont.)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Input Leakage Current	$I_{I(LEAK)}$	$V_{CC}=0 \sim 3.6V, V_{IN}=GND \sim 3.6V$			± 0.1	μA
Power OFF Leakage Current	I_{off}	$V_{CC}=0V, V_{IN} \text{ or } V_{OUT}=0 \sim 3.6V$			± 0.2	μA
Additional Power OFF Leakage Current	ΔI_{off}	$V_{CC}=0V \sim 0.2V, V_{IN} \text{ or } V_{OUT}=0 \sim 3.6V$			± 0.2	μA
Quiescent Supply Current	I_{CC}	$V_{CC}=0.8 \sim 3.6V, V_{IN}=V_{CC} \text{ or } GND, I_{OUT}=0$			0.5	μA
Additional Quiescent Supply Current Per Input Pin	ΔI_{CC}	$V_{CC}=3.3V, V_{IN}=V_{CC}-0.6V, I_{OUT}=0$			40	μA
Input Capacitance	C_I	$V_{CC}=0V, V_{IN}=V_{CC} \text{ or } GND$ $V_{CC}=3.6V, V_{IN}=V_{CC} \text{ or } GND$		1.5		pF
Output Capacitance	C_{OUT}	$V_{CC}=0V, V_{OUT}=GND$	3			pF

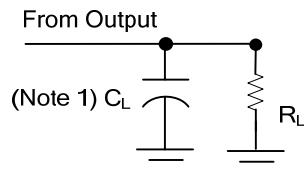
■ SWITCHING CHARACTERISTICS ($T_A = 25^\circ C$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Propagation delay from inputs (A or B) to output(Y)	t_{PD}	$V_{CC}=0.8V$		21.2		ns
		$V_{CC}=1.2 \pm 0.1V$	2.3	5.9		ns
		$V_{CC}=1.5 \pm 0.1V$	1.8	4.1		ns
		$V_{CC}=1.8 \pm 0.15V$	1.5	3.3		ns
		$V_{CC}=2.5 \pm 0.2V$	1.2	2.6		ns
		$V_{CC}=3.3 \pm 0.3V$	1	2.3		ns
		$V_{CC}=0.8V$		24.7		ns
		$V_{CC}=1.2 \pm 0.1V$	2.6	6.8		ns
		$V_{CC}=1.5 \pm 0.1V$	2.2	4.8		ns
		$V_{CC}=1.8 \pm 0.15V$	1.8	3.9		ns
		$V_{CC}=2.5 \pm 0.2V$	1.5	3.1		ns
		$V_{CC}=3.3 \pm 0.3V$	1.3	2.9		ns
		$V_{CC}=0.8V$		28.2		ns
		$V_{CC}=1.2 \pm 0.1V$	3.0	7.6		ns
		$V_{CC}=1.5 \pm 0.1V$	2.4	5.3		ns
		$V_{CC}=1.8 \pm 0.15V$	2.1	4.4		ns
		$V_{CC}=2.5 \pm 0.2V$	1.8	3.6		ns
		$V_{CC}=3.3 \pm 0.3V$	1.6	3.3		ns
		$V_{CC}=0.8V$		38.5		ns
		$V_{CC}=1.2 \pm 0.1V$	3.9	9.9		ns
		$V_{CC}=1.5 \pm 0.1V$	3.2	6.9		ns
		$V_{CC}=1.8 \pm 0.15V$	2.8	5.7		ns
		$V_{CC}=2.5 \pm 0.2V$	2.4	4.7		ns
		$V_{CC}=3.3 \pm 0.3V$	2.2	4.4		ns

■ OPERATING CHARACTERISTICS ($f=1MHz, T_A = 25^\circ C$, unless otherwise specified)

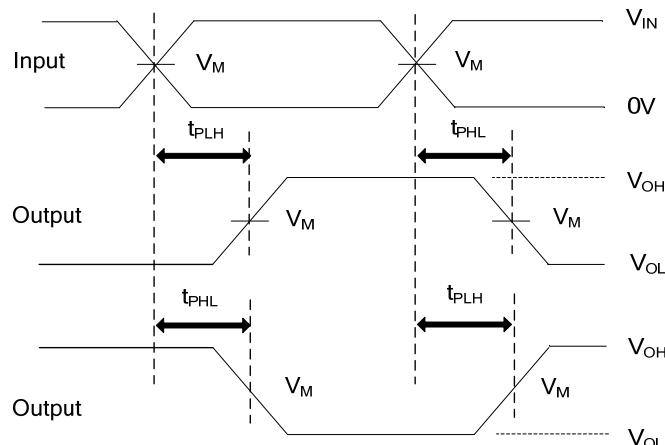
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Power Dissipation Capacitance	C_{PD}	$V_{CC}=0.8V$		2.7		pF
		$V_{CC}=1.2 \pm 0.1V$		2.9		pF
		$V_{CC}=1.5 \pm 0.1V$		3.0		pF
		$V_{CC}=1.8 \pm 0.15V$		3.1		pF
		$V_{CC}=2.5 \pm 0.2V$		3.6		pF
		$V_{CC}=3.3 \pm 0.3V$		4.2		pF

■ TEST CIRCUIT AND WAVEFORMS



TEST CIRCUIT

V_{CC}	V_{IN}	t_R / t_F	V_M	C_L	R_L
0.8V	V_{CC}	$\leq 3\text{ns}$	$V_{CC}/2$	5,10,15,30pF	$1M\Omega$
$1.2V \pm 0.1V$	V_{CC}	$\leq 3\text{ns}$	$V_{CC}/2$	5,10,15,30pF	$1M\Omega$
$1.5V \pm 0.1V$	V_{CC}	$\leq 3\text{ns}$	$V_{CC}/2$	5,10,15,30pF	$1M\Omega$
$1.8V \pm 0.15V$	V_{CC}	$\leq 3\text{ns}$	$V_{CC}/2$	5,10,15,30pF	$1M\Omega$
$2.5V \pm 0.2V$	V_{CC}	$\leq 3\text{ns}$	$V_{CC}/2$	5,10,15,30pF	$1M\Omega$
$3.3V \pm 0.3V$	V_{CC}	$\leq 3\text{ns}$	$V_{CC}/2$	5,10,15,30pF	$1M\Omega$



PROPAGATION DELAY TIMES

Notes: 1. C_L includes probe and jig capacitance.
2. All input pulses are supplied by generators having the following characteristics: PRR $\leq 10\text{MHz}$, $Z_0 = 50\Omega$.

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